Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/551,539	SCHON ET AL.	
Examiner	Art Unit	
Ching Chang	3748	

SEARCHED					
Class	Subclass	Date	Examiner		
123	90.16	11/30/06	UL		
123	90.2	1			
13	90.39				
13					
123	90.4/				
74	559				
74	567				
74	569	l			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Seach	12/1/06	cc
Assignee Search		